

Search Notes

Application/Control No.

10/701,156

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under
Reexamination

IWATA, YUJI

Art Unit

2861

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------------------------------|-----------|----------|
| 347 | 100-102, 15,43,105 125,128 | 12/8/2005 | SWH |
| 392 | 417 | 12/8/2005 | SWH |
| 34 | 266-267 | 12/8/2005 | SWH |
| 34 | 273 | 12/8/2005 | SWH |
| 219 | 216 | 12/8/2005 | SWH |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---------------------------------|-----------|------|
| east text search (see attached) | 12/7/2005 | SWH |
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